TS5V330 QUAD SPDT WIDE-BANDWIDTH VIDEO SWITCH WITH LOW ON-STATE RESISTANCE

D, DBQ, OR PW PACKAGE

(TOP VIEW)

16 Vcc

15 🛛 EN

14 S1_D

13 S2D

12 DDD

11 S1_C

10 S2_C

9 🛛 D_C

V_CC

16

9

2

15 EN

14 S1_D

13 S2n

12 D_D

11 S1_C

10 S2_C

IN [

2

3

8

z

1

GND

RGY PACKAGE

(TOP VIEW)

S1_A

S2_A

D_A [] 4

S1_B 🛛 5

S2_B 🛛 6

D_B [] 7

GND [

S1_A

S2_A3

 D_A

S1_B 5

S2_B6

D_B7

2

4

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FEATURES

- Low Differential Gain and Phase (D_G = 0.64%, D_P = 0.1 Degrees Typ)
- Wide Bandwidth (BW = 300 MHz Min)
- Low Crosstalk (X_{TALK} = -63 dB Typ)
- Low Power Consumption (I_{CC} = 3 μA Max)
- Bidirectional Data Flow With Near-Zero
 Propagation Delay
- Low ON-State Resistance (r_{on} = 3 Ω Typ)
- V_{cc} Operating Range From 4.5 V to 5.5 V
- I_{off} Supports Partial-Power-Down Mode Operation
- Data and Control Inputs Provide Undershoot Clamp Diode
- Control Inputs Can Be Driven by TTL or 5-V/3.3-V CMOS Outputs
- Latch-Up Performance Exceeds 100 mA Per JESD 78, Class II
- ESD Performance Tested Per JESD 22
 - 2000-V Human-Body Model (A114-B, Class II)
 - 1000-V Charged-Device Model (C101)
- Suitable for Both RGB and Composite-Video
 Switching

DESCRIPTION/ORDERING INFORMATION

The TS5V330 video switch is a 4-bit 1-of-2 multiplexer/demultiplexer with a single switch-enable (\overline{EN}) input. When \overline{EN} is low, the switch is enabled and the D port is connected to the S port. When \overline{EN} is high, the switch is disabled and the high-impedance state exists between the D and S ports. The select (IN) input controls the data path of the multiplexer/demultiplexer.

Low differential gain and phase make this switch ideal for composite and RGB video applications. This device has wide bandwidth and low crosstalk, making it suitable for high-frequency applications as well.

This device is fully specified for partial-power-down applications using I_{off} . The I_{off} feature ensures that damaging current will not backflow through the device when it is powered down. This switch maintains isolation during power off.

T _A	PACKA	(GE ⁽¹⁾	ORDERABLE PART NUMBER	TOP-SIDE MARKING	
	QFN – RGY	Tape and reel	TS5V330RGYR	TE330	
	SOIC – D	Tube	TS5V330D	T051/220	
	50IC - D	Tape and reel	TS5V330DR	- TS5V330	
–40°C to 85°C	SSOP (QSOP) – DBQ	Tape and reel	TS5V330DBQR	TE330	
		Tube	TS5V330PW	TEDDO	
	TSSOP – PW	Tape and reel	TS5V330PWR	- TE330	

ORDERING INFORMATION

(1) Package drawings, standard packing quantities, thermal data, symbolization, and PCB design guidelines are available at www.ti.com/sc/package.



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DESCRIPTION/ORDERING INFORMATION (CONTINUED)

To ensure the high-impedance state during power up or power down, \overline{EN} should be tied to V_{CC} through a pullup resistor; the minimum value of the resistor is determined by the current-sinking capability of the driver.

FUNCTION TABLE							
INP	UTS	INPUT/OUTPUT	FUNCTION				
EN	IN	D	FUNCTION				
L	L	S1	D port = S1 port				
L	Н	S2	D port = S2 port				
н	Х	Z	Disconnect				

PIN	DESCRIPTION	

PIN	DESCRIPTION
S1, S2	Analog video I/Os
D	Analog video I/Os
IN	Select input
EN	Switch-enable input

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PARAMETER DEFINITIONS

PARAMETER	DESCRIPTION
r _{on}	Resistance between the D and S ports, with the switch in the ON state
I _{OZ}	Output leakage current measured at the D and S ports, with the switch in the OFF state
I _{OS}	Short-circuit current measured at the I/O pins
V _{IN}	Voltage at IN
V _{EN}	Voltage at EN
C _{IN}	Capacitance at the control (EN, IN) inputs
C _{OFF}	Capacitance at the analog I/O port when the switch is OFF
C _{ON}	Capacitance at the analog I/O port when the switch is ON
V _{IH}	Minimum input voltage for logic high for the control (EN, IN) inputs
V _{IL}	Minimum input voltage for logic low for the control (EN, IN) inputs
V _{hys}	Hysteresis voltage at the control (EN, IN) inputs
V _{IK}	I/O and control (EN, IN) inputs diode clamp voltage
VI	Voltage applied to the D or S pins when D or S is the switch input
Vo	Voltage applied to the D or S pins when D or S is the switch output
I _{IH}	Input high leakage current of the control (EN, IN) inputs
IIL	Input low leakage current of the control (EN, IN) inputs
I _I	Current into the D or S pins when D or S is the switch input
Ι _Ο	Current into the D or S pins when D or S is the switch output
I _{off}	Output leakage current measured at the D or S ports, with $V_{CC} = 0$
t _{ON}	Propagation delay measured between 50% of the digital input to 90% of the analog output when switch is turned ON
t _{OFF}	Propagation delay measured between 50% of the digital input to 90% of the analog output when switch is turned OFF
BW	Frequency response of the switch in the ON state measured at -3 dB
X _{TALK}	Unwanted signal coupled from channel to channel. Measured in –dB. X _{TALK} = 20 log V _O /V _I . This is a nonadjacent crosstalk.
O _{IRR}	Off isolation is the resistance (measured in –dB) between the input and output with the switch OFF.
D_G	Magnitude variation between analog input and output pins when the switch is ON and the dc offset of composite-video signal varies at the analog input pin. In the NTSC standard, the frequency of the video signal is 3.58 MHz, and dc offset is from 0 to 0.714 V.
D _P	Phase variation between analog input and output pins when the switch is ON and the dc offset of composite-video signal varies at the analog input pin. In the NTSC standard, the frequency of the video signal is 3.58 MHz, and dc offset is from 0 to 0.714 V.
I _{CC}	Static power-supply current
I _{CCD}	Variation of I_{CC} for a change in frequency in the control (\overline{EN} , IN) inputs
ΔI_{CC}	This is the increase in supply current for each control input that is at the specified voltage level, rather than V _{CC} or GND.

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Absolute Maximum Ratings⁽¹⁾

over operating free-air temperature range (unless otherwise noted)

			MIN	MAX	UNIT
V_{CC}	Supply voltage range		-0.5	7	V
V _{IN}	Control input voltage range ⁽²⁾⁽³⁾		-0.5	7	V
V _{I/O}	Switch I/O voltage range ⁽²⁾⁽³⁾⁽⁴⁾		-0.5	7	V
I _{IK}	Control input clamp current	V _{IN} < 0		-50	mA
I _{I/OK}	I/O port clamp current	V _{I/O} < 0		-50	mA
I _{I/O}	ON-state switch current ⁽⁵⁾			±128	mA
	Continuous current through V _{CC} or GND			±100	mA
		D package ⁽⁶⁾		73	
0	Declarge the model in a decar	DBQ package ⁽⁶⁾		90	°C/W
θ_{JA}	Package thermal impedance	PW package ⁽⁶⁾		108	°C/VV
		RGY package ⁽⁷⁾		39	
T _{stg}	Storage temperature range		-65	150	°C

(1) Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

(2) All voltages are with respect to ground, unless otherwise specified.

(3) The input and output voltage ratings may be exceeded if the input and output clamp-current ratings are observed.

(4) V_I and V_O are used to denote specific conditions for $V_{I/O}$.

(5) I_{I} and I_{O} are used to denote specific conditions for $I_{I/O}$.

(6) The package thermal impedance is calculated in accordance with JESD 51-7.

(7) The package thermal impedance is calculated in accordance with JESD 51-5.

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Recommended Operating Conditions⁽¹⁾

		MIN	MAX	UNIT
V _{CC}	Supply voltage	4	5.5	V
V _{IH}	High-level control input voltage (EN, IN)	2	5.5	V
V _{IL}	Low-level control input voltage (EN, IN)	0	0.8	V
V _{ANALOG}	Analog I/O voltage	0	2	V
T _A	Operating free-air temperature	-40	85	°C

All unused control inputs of the device must be held at V_{CC} or GND to ensure proper device operation. Refer to the TI application report, *Implications of Slow or Floating CMOS Inputs*, literature number SCBA004. (1)

Electrical Characteristics

over recommended operating free-air temperature range, V_{CC} = 5 V ±10% (unless otherwise noted)

PARA	AMETER		TE	ST CONDITIONS ⁽¹⁾		MIN	TYP ⁽²⁾	MAX	UNIT
V _{IK}	ĒN, IN	$V_{CC} = 4.5 V,$	I _{IN} = -18 MA					-1.8	V
V _{hys}	ĒN, IN						150		mV
I _{IH}	ĒN, IN	$V_{CC} = 5.5 V$,	V_{IN} and $V_{EN} = V_{CC}$					±1	μA
I_{IL}	ĒN, IN	$V_{CC} = 5.5 V,$	V_{IN} and $V_{EN} = GND$	3				±1	μA
$I_{OZ}^{(3)}$		$V_{CC} = 5.5 V,$	$V_0 = 0$ to 5.5 V,	$V_{I} = 0,$	Switch OFF			±1	μA
$I_{OS}^{(4)}$		$V_{CC} = 5.5 V,$	$V_{O} = 0.5 V_{CC,}$	V ₁ = 0,	Switch ON	50			mA
I _{off}		$V_{CC} = 0 V$,	$V_0 = 0$ to 5.5 V,	V ₁ = 0				1	μΑ
I _{CC}		$V_{CC} = 5.5 V$,	$I_{I/O}=0,$	Switch ON or OFF				3	μA
ΔI_{CC}	ĒN, IN	$V_{CC} = 5.5 V,$	One input at 3.4 V,	Other inputs at V_{CC}	or GND			2.5	mA
I _{CCD}		V _{CC} = 5.5 V,	V _{EN} = GND,	D and S ports open,	V _{IN} input switching 50% duty cycle			0.25	mA/MHz
C _{IN}	ĒN, IN	V_{IN} of $V_{EN} = 0$,	,	f = 1 MHz			3.5		pF
<u> </u>	D port	V 0	£ 4 MUL				6		~ Г
C _{OFF}	S port	$V_{I} = 0,$	f = 1 MHz,	Outputs open,	Switch OFF		4		pF
C _{ON}		$V_{I} = 0,$	f = 1 MHz,	Outputs open,	Switch ON		14		pF
		$V_{CC} = 4.5 V,$ $V_{I} = 1 V,$		I _O = 13 mA,	R _L = 75 Ω		3	7	0
r _{on} ⁽⁵⁾		$v_{\rm CC} = 4.5 \ v_{\rm c}$	V _I = 2 V,	I _O = 26 mA,	R _L = 75 Ω		7	10	Ω

(1)

(2)

(3)

(4)

 V_{I} , V_{O} , I_{I} , and I_{O} refer to I/O pins. All typical values are at $V_{CC} = 5 V$ (unless otherwise noted), $T_{A} = 25^{\circ}C$. For I/O ports, I_{OZ} includes the input leakage current. The I_{OS} test is applicable to only one ON channel at a time. The duration of this test is less than one second. Measured by the voltage drop between the D and S terminals at the indicated current through the switch. ON-state resistance is determined by the lower of the voltage of the two (D or S) terminals (5) determined by the lower of the voltages of the two (D or S) terminals.

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Switching Characteristics

over recommended operating free-air temperature range, $V_{CC} = 5 \text{ V} \pm 10\%$, $R_{L} = 75 \Omega$, $C_{L} = 20 \text{ pF}$ (unless otherwise noted) (see Figure 5)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	MIN	ТҮР	МАХ	UNIT
t _{ON}	S	D		2.5	6	ns
t _{OFF}	S	D		1.1	6	ns

TEXAS STRUMENTS

www.ti.com

Dynamic Characteristics

over recommended operating free-air temperature range, V_{CC} = 5 V \pm 10% (unless otherwise noted)

PARAMETER		TEST CONDITIONS				
D _G ⁽²⁾	R _L = 150 Ω,	f = 3.58 MHz,	See Figure 6	0.64	%	
D _P ⁽²⁾	R _L = 150 Ω,	f = 3.58 MHz,	See Figure 6	0.1	Deg	
BW	R _L = 150 Ω,		See Figure 7	300	MHz	
X _{TALK}	R _L = 150 Ω,	$f = 10 \text{ MHz}, \text{ RIN} = 10 \Omega,$	See Figure 8	-63	dB	
O _{IRR}	R _L = 150 Ω,	f = 10 MHz,	See Figure 9	-60	dB	

 $\begin{array}{ll} \mbox{(1)} & \mbox{All typical values are at } V_{CC} = 5 \mbox{ V (unless otherwise noted)}, \mbox{ } T_A = 25^\circ C. \\ \mbox{(2)} & \mbox{ } D_G \mbox{ and } D_P \mbox{ are expressed in absolute magnitude.} \end{array}$

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OPERATING CHARACTERISTICS





Figure 1. Gain/Phase vs Frequency



Figure 2. Differential Gain/Phase vs V_{BIAS}

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OPERATING CHARACTERISTICS



Phase at 10 MHz, 88.5 Degrees
 Off Isolation at 10 MHz, -60 dB

Figure 3. Off Isolation vs Frequency





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PARAMETER MEASUREMENT INFORMATION



TEST	V _{CC}	RL	CL	V _{S1}	V _{S2}
t _{ON}	5 V \pm 0.5 V	75	20	GND	3 V
FON	5 V \pm 0.5 V	75	20	3 V	GND
tOFF	5 V \pm 0.5 V	75	20	GND	3 V
	5 V \pm 0.5 V	75	20	3 V	GND



NOTES: A. C_L includes probe and jig capacitance.

- B. All input pulses are supplied by generators having the following characteristics: PRR \leq 10 MHz, Z₀ = 50 Ω , t_r \leq 2.5 ns, t_f \leq 2.5 ns.
- C. The outputs are measured one at a time, with one transition per measurement.

Figure 5. Test Circuit and Voltage Waveforms

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PARAMETER MEASUREMENT INFORMATION



NOTE A: For additional information on measurement method, refer to the TI application report, *Measuring Differential Gain and Phase*, literature number SLOA040.

Figure 6. Test Circuit for Differential Gain/Phase Measurement

Differential gain and phase are measured at the output of the ON channel. For example, when $V_{IN} = 0$, $V_{EN} = 0$, and DA is the input, the output is measured at S1_A.

HP8753ES Setup

Average = 20 RBW = 300 Hz ST = 1.381 s P1 = -7 dBM CW frequency = 3.58 MHz

Sawtooth Waveform Generator Setup

 $V_{BIAS} = 0$ to 1 V Frequency = 0.905 Hz

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PARAMETER MEASUREMENT INFORMATION





Frequency response is measured at the output of the ON channel. For example, when $V_{IN} = 0$, $V_{EN} = 0$, and D_A is the input, the output is measured at S1_A. All unused analog I/O ports are left open.

HP8753ES Setup

 $\begin{array}{l} \text{Average} = 4 \\ \text{RBW} = 3 \ \text{Hz} \\ \text{V}_{\text{BIAS}} = 0.35 \ \text{V} \\ \text{ST} = 2 \ \text{s} \\ \text{P1} = 0 \ \text{dBM} \end{array}$

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PARAMETER MEASUREMENT INFORMATION



(1) A 50- Ω termination resistor is needed for the network analyzer.

Figure 8. Test Circuit for Crosstalk (X_{TALK})

Crosstalk is measured at the output of the nonadjacent ON channel. For example, when $V_{IN} = 0$, $V_{EN} = 0$, and D_A is the input, the output is measured at S1_B. All unused analog input (D) ports and output (S) ports are connected to GND through 10- Ω and 50- Ω pulldown resistors, respectively.

HP8753ES Setup

Average = 4 RBW = 3 kHz $V_{BIAS} = 0.35 V$ ST = 2 s P1 = 0 dBM

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PARAMETER MEASUREMENT INFORMATION



(1) A 50- Ω termination resistor is needed for the network analyzer.

Figure 9. Test Circuit for Off Isolation (O_{IRR})

Off isolation is measured at the output of the OFF channel. For example, when $V_{IN} = V_{CC}$, $V_{EN} = 0$, and D_A is the input, the output is measured at S1_A. All unused analog input (D) ports are left open, and output (S) ports are connected to GND through 50- Ω pulldown resistors.

HP8753ES Setup

Average = 4 RBW = 3 kHz V_{BIAS} = 0.35 V ST = 2 s P1 = 0 dBM V IEXAS NSTRUMENTS www.ti.com

PACKAGING INFORMATION

Orderable Device	Status ⁽¹⁾	Package Type	Package Drawing	Pins	Packag Qty	e Eco Plan ⁽²⁾	Lead/Ball Finish	MSL Peak Temp ⁽³⁾
TS5V330D	ACTIVE	SOIC	D	16	40	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
TS5V330DBQR	ACTIVE	SSOP/ QSOP	DBQ	16	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1YEAR
TS5V330DBQRE4	ACTIVE	SSOP/ QSOP	DBQ	16	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1YEAR
TS5V330DE4	ACTIVE	SOIC	D	16	40	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
TS5V330DR	ACTIVE	SOIC	D	16	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
TS5V330DRE4	ACTIVE	SOIC	D	16	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
TS5V330PW	ACTIVE	TSSOP	PW	16	90	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
TS5V330PWE4	ACTIVE	TSSOP	PW	16	90	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
TS5V330PWR	ACTIVE	TSSOP	PW	16	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
TS5V330PWRE4	ACTIVE	TSSOP	PW	16	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
TS5V330RGYR	ACTIVE	QFN	RGY	16	1000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1YEAR

⁽¹⁾ The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS) or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details. TBD: The Pb-Free/Green conversion plan has not been defined.

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Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

⁽³⁾ MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

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D (R-PDSO-G16)

PLASTIC SMALL-OUTLINE PACKAGE



NOTES: A. All linear dimensions are in inches (millimeters).

B. This drawing is subject to change without notice.

C. Body dimensions do not include mold flash or protrusion not to exceed 0.006 (0,15).

D. Falls within JEDEC MS-012 variation AC.



MECHANICAL DATA



Pin 1 identifiers are located on both top and bottom of the package and within the zone indicated. The Pin 1 identifiers are either a molded, marked, or metal feature.

F. Package complies to JEDEC MO-241 variation BB.



DBQ (R-PDSO-G16)

PLASTIC SMALL-OUTLINE PACKAGE



NOTES: A. All linear dimensions are in inches (millimeters).

B. This drawing is subject to change without notice.

C. Body dimensions do not include mold flash or protrusion not to exceed 0.006 (0,15) per side.

D. Falls within JEDEC MO-137 variation AB.



MECHANICAL DATA

MTSS001C - JANUARY 1995 - REVISED FEBRUARY 1999

PW (R-PDSO-G**)

PLASTIC SMALL-OUTLINE PACKAGE

14 PINS SHOWN



NOTES: A. All linear dimensions are in millimeters.

- B. This drawing is subject to change without notice.
- C. Body dimensions do not include mold flash or protrusion not to exceed 0,15.
- D. Falls within JEDEC MO-153



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